

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/877,210	ONISHI ET AL.
Examiner	Art Unit	
Yixing Qin	2622	

**SEARCHED**

<b>INTERFERENCE SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
358	1.15	1/20/2005	YQ
358	1.16	1/20/2006	YQ